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# APPROVAL SHEET

Customer Name	:	
Customer P/N	:	
Frequency	:	25.000000 MHz
Aker Approved P/N		SMBN-025000-7-D4-00
Aker MPN		SMBN-025000-7-D4-00
Rev.		1
ISSUE DATE		Feb.13.2023

APPROVED	CHECKED	PREPARED
(in		Xīn
APPROVED BY CUST	OMER	

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MSL:Level 1 RoHS compliant



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Rev.	Date	Reviser	Revise contents
1	2023/2/13	Xin	Initial Released



Aker Approved P	P/N :	SMBN	-025000-7-D4-00
APPROVED	:	Tin	SHEET : 2 of 10
PREPARED	:	Xin	REV. : 1

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# SMD CRYSTAL OSCILLATOR

#### **1. ELECTRICAL CHARACTERISTICS**

Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurement

and tests are as follow :

Ambient temperature :  $25\pm5$  °C

Relative humidity : 40%~70%

If there is any doubt about the results, measurement shall be made within the following limits:

Ambient temperature : 25±3 °C

Relative humidity : 40%~70%

■ AKER Model : SMBN-751

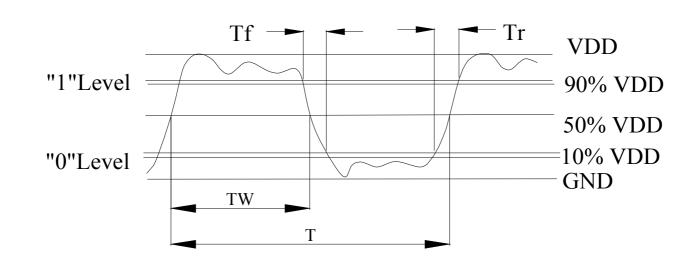
• Cutting Mode : AT CUT

			Electrical Spec			
Parameters	Symbol	Min.	Тур.	Max.	Units.	Notes
Nominal Frequency		2	5.00000	0	MHz	
Frequency Stability			±100		ppm	
Supply Voltage	Vcc	1.62	~	3.63	V	
Output Load CMOS	CL			15	pF	
Aging			$\pm 3$		ppm	First Year
Enable Control			Yes			Pad 1
Operating Temperature		-40	25	105	°C	
Storage Temperature Range		-55	~	125	°C	
Output Voltage High	VoH	90%Vdd			V	
Output Voltage Low	VoL			10%Vdd	V	
Input Current	Icc			12	mA	
Standby Current	Ist			20	μA	
Rise Time	Tr			10	ns	10%~90%VDD Level
Fall Time	Tf			10	ns	90%~10%VDD Level
Symmetry (Duty ratio)	TH/T	45	~	55	%	
Start-up Time	Tosc			10	ms	
Enable Voltage High	Vhi	70%Vdd			V	
Disable Voltage Low	Vlo			30%VDD	V	
Output Enable Delay Time	T on			10	ms	
Output Disable Delay Time	T off			200	ns	
Phase Jitter RMS				1	ps	12KHz~5MHz

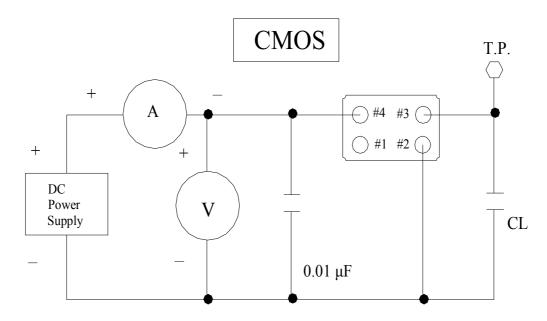


Aker Approved P/	N :	SMBN-	025000-7-D4-00			
APPROVED	:	Tin	SHEET : 3 of 10			
PREPARED	:	Xin	REV. : 1			
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## 2. C - MOS LOAD OUTPUT WAVEFORM



## **3.C-MOS LOAD TEST CIRCUIT**

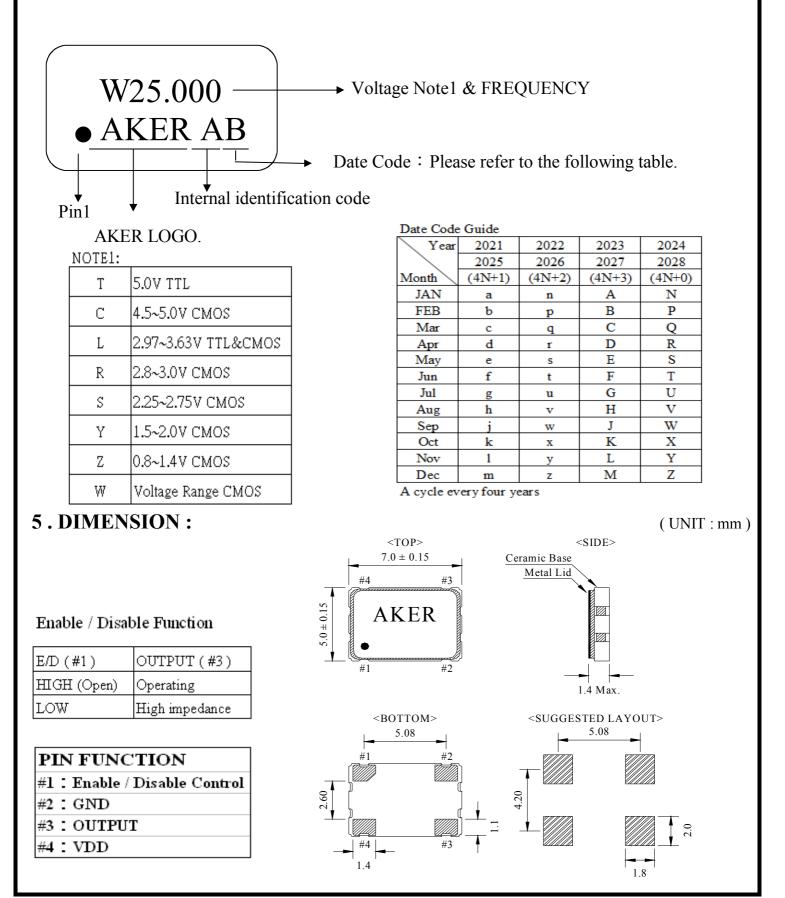


\*\*\*Because SMA series has no by pass capacitor. So,we recommend our customer to use capacitor  $0.01 \ \mu F$  in join Vcc and GND.



Aker Approved P/N	1:	SMBN-025	5000-7-D4-00
APPROVED	:	Tin	SHEET : 4 of 10
PREPARED	:	Xin	REV. : 1
			Confidential

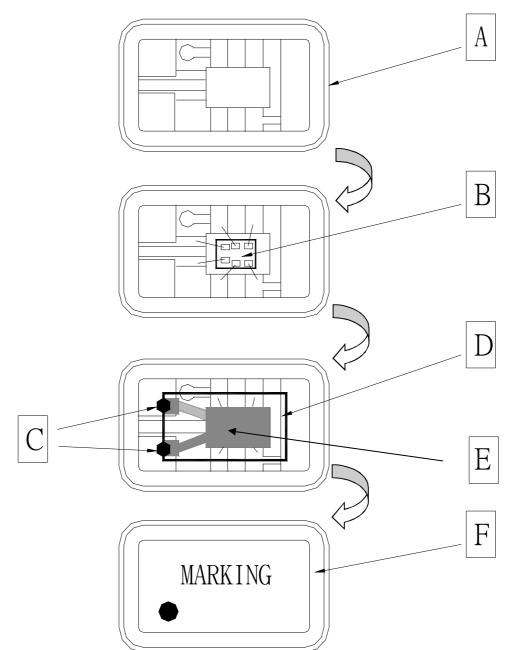
#### 4. MARKING :





Aker Approved P	/N :	SMBN	-025000-7-D4-00
APPROVED	:	Tin	SHEET : 5 of 10
PREPARED	:	Xin	REV. : 1
			Confidential

# **6** . STRUCTURE ILLUSTRATION

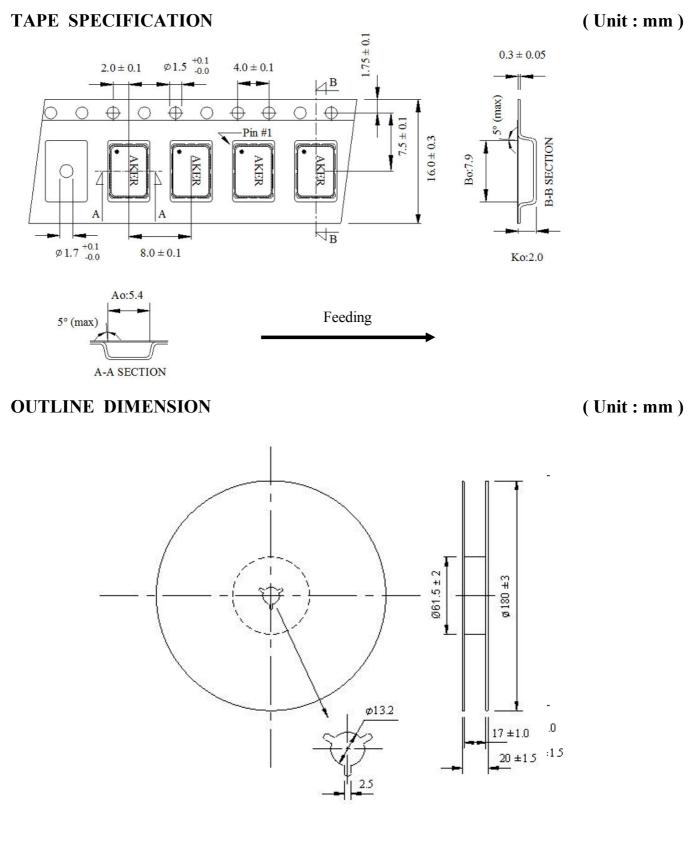


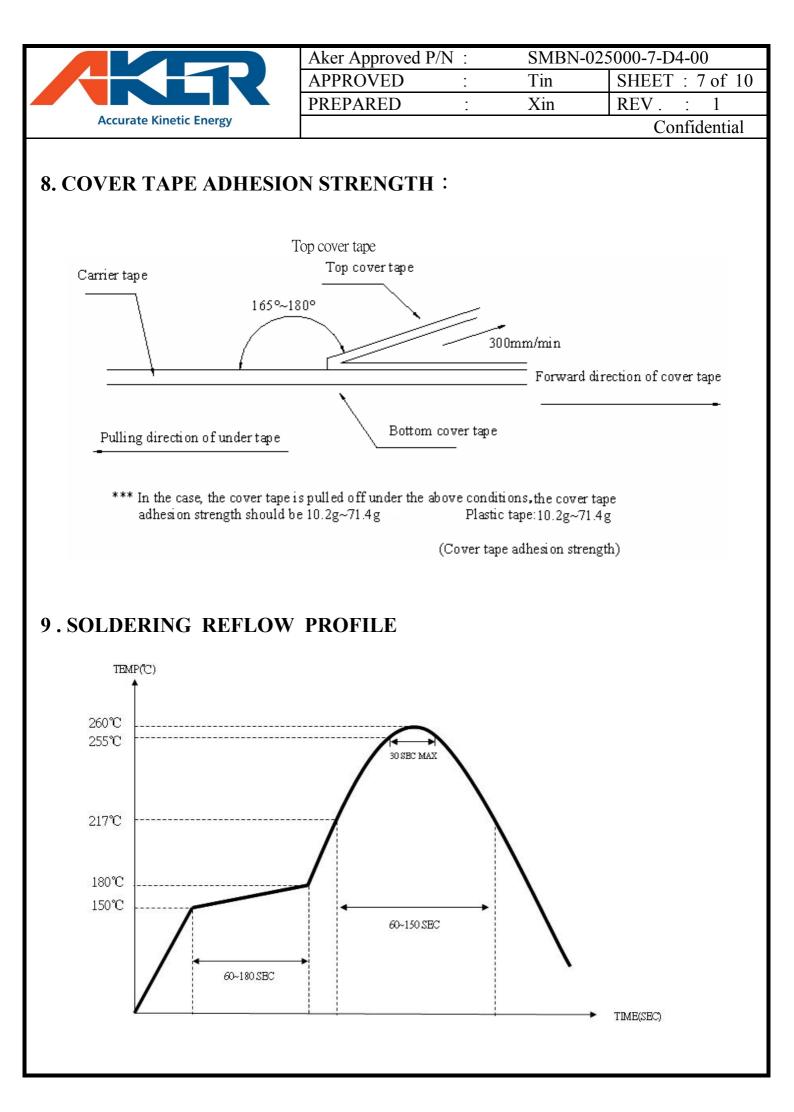
	COMPONENTS	MATERIALS	CO	MPONENTS	MATERIALS
A	Base (Package)	Ceramic (Al2O3)+Kovar (Fe/Co/Ni)	D	Crystal blank	SiO2
В	IC chip		E	Electrode	Cr / Ag
С	Conductive adhesive	Ag / Silicon resin	F	Lid	Fe/Co/Ni

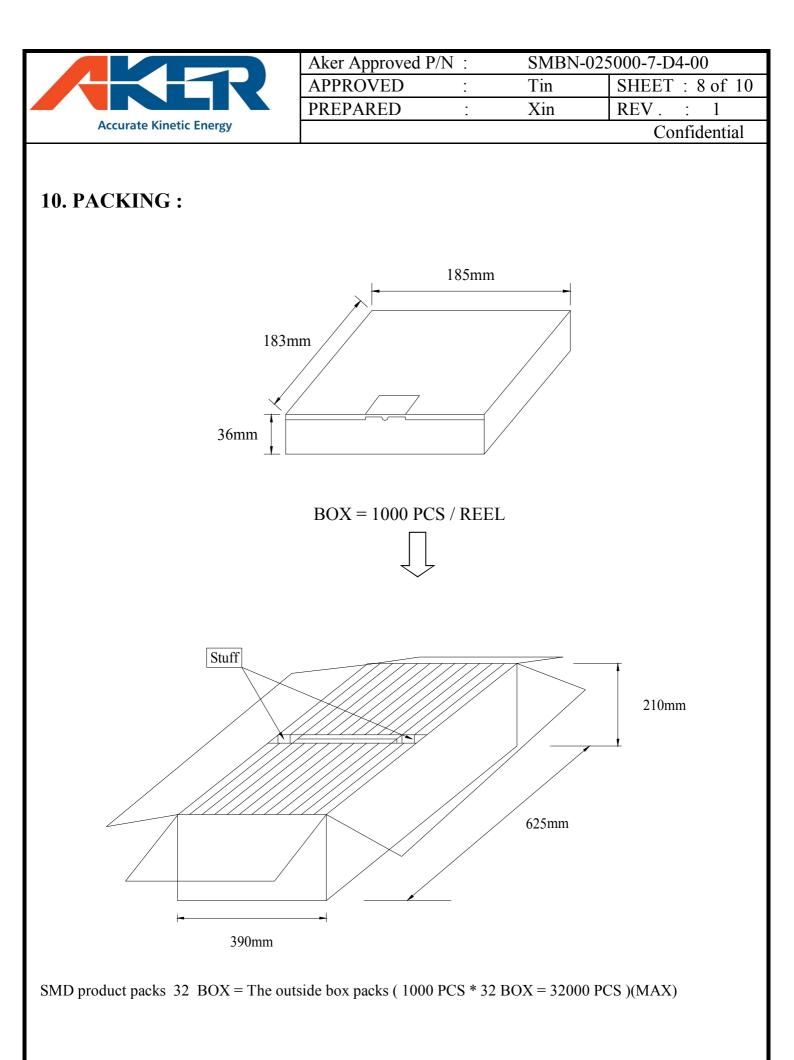


Aker Approved P/N	•	SMBN-025	SMBN-025000-7-D4-00		
APPROVED	:	Tin	SHEET : 6 of 10		
PREPARED	•	Xin	REV. : 1		
			Confidential		

### 7. PACKING :









Aker Approved P	P/N :	SMBN-	-025000-7-D4-00
APPROVED	•	Tin	SHEET : 9 of 10
PREPARED	:	Xin	REV. : 1
			Confidential

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# **11. MECHANICAL PERFORMANCE**

TEST ITEMS	TEST METHODS AND TEST CONDITION	PERFORMANCE
11.1 Drop Test	The specimen is measured for its frequency before the test. It is then dropped from a hight of 75 cm or more as a free fall object onto a hard wooden plate of 30mm or more in thickness. ( in accordance with JIS-C0044 )	
11.2 Vibration TestThe specimen is measured for its frequency before the test. Most them into X,Y and Z axes, respectively, for the vibration test. Vibration condition: Frequency range ; 20 ~ 2000HZ Peak to peak amplitude : 1.52 mm Peak acceleration : 20G Sweep time : 20 minute / axis Pendicular total test time : 4 hours		To satisfy the electrical performance .
11.3 Resistance to	( in accordance with MIL-STD-883F : 2007.3 )	_
Soldering Test	The specimen is measured for its frequency before the test. Place the specimen on	
Solucing rest	the belt of the converynace and let it pass through	
	the reflow with the presetted temperature condition.	
	After passing twice the reflow place, the specimen	
	under the referee condition for -~2 hours and then	
	measure its electrical performance.	
	Temperature Condition of IR Simulation:	
	The temperature range of the preheated section	
	is setted at $150 \ \ 180^{\circ}$ C for $60 \ \ 120$ sec. For the next	
	section the temperature range is setted at $217 \sim 260^{\circ}$ C	
	for $45 \sim 90$ sec. and within this time range the specimen	
	should be able to sustain at the peak temperature,	
	$260+/-3^{\circ}$ °C , for 10 sec long.	
	( in accordance with JESD22-B106-B )	
11.4 Fine Leak	Place the specimen in a pressurized container and	
Test	pressurize it with the detection gas (mixed gas	Less than
	consisting of 95% or more helium ) for at least 2 hours.	$1.0 * 10^{-8}$ atm .c.c. / sec,
	Complete the measurement of the concentration of	Helium
	helium within 30 min after taking it out from the	
	pressurized container.	
	( in accordance with MIL-STD-883F : 1014.11 )	
	The referee condition .	•
	Temperature $25 \pm 2$ °C	
	Humidity $44 \approx 55\%$	
	Pressure $86 \sim 106 \text{ kPa}$	
	(in accordance with MIL-STD-883E:1014.9)	



	Aker Approved P/N :		SMBN-025	SMBN-025000-7-D4-00	
2	APPROVED	:	Tin	SHEET : 10 of 10	
	PREPARED	:	Xin	REV. : 1	
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# **12. CLIMATIC RESISTANCE**

TEST ITEMS	TEST METHODS AND TEST CONDITION	PERFORMANCE
12.1 Low Temp Exposure Test	The specimen is measured for its frequency before the test . Place the specimen in the chamber and kept it at the temperature of $-40 \pm 3^{\circ}$ C for $168 \pm 6$ hours . Take the specimen out of the chamber and measure itselectrical performance after leaving 1 ~ 2 hours under the referee condition. ( in accordance with JIS-C0020 )	
12.2 Aging Test	The specimen is measured for its frequency before the test . Place the specimen in the testing chamber and keep it at the temperature of $+ 125 \pm 3^{\circ}$ C for $720 \pm 48$ hours. And then take the specimen out of the chamber and measure its electrical performance after leaving for 1 ~ 2 hours under the referee condition . ( in accordance with JIS-C0021 )	To satisfy the electrical performance .
12.3 High Temperature & High Humidty	The specimen is measured for its frequency before the test . Place the specimen in the testing chamber and kept it at the temperature of $+ 85 \pm 5$ °C and humidity of $85 \pm 5$ % for $168 \pm 6$ hours.and then take the specimen out and measure its electrical performance after leaving for 1 ~ 2 hours under the referee condition. ( in accordance with MIL-STD-883F : 1004.7 )	
12.4 Temperature Cycle Test	The specimen is measured for its frequency before the test . Subject the specimen to the 100 cycles of temperature ranges stated below . High temp $. + 125 \pm 3 \degree C$ ( $15\pm 3 \min$ ). $2\sim 3 \min$ $2\sim 3 \min$ . Low temp $55 \pm 3 \degree C$ ( $15\pm 3 \min$ ). Measure its electrical performance after leaving it for 1 ~ 2 hours under the referee condition . ( in accordance with MIL-STD-883F : 1010.8 )	